Search Notes

Application/Control No.	Ontrol No. Applicant(s)/Patent under Reexamination	
10/667,790	TOGAWA, YOSHIFUSA	
Examiner	Art Unit	
Eric Chang	2116	

	SEAR	CHED	
Class	Subclass	Date	Examiner
713	320	12/11/2006	EC
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INT	TERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST USPAT/PGPUB EPO/JPO	12/11/2006	EC